

Search Notes

Application/Control No.

10/694,067

Examiner

Trinh T. Nguyen

Applicant(s)/Patent under
Reexamination

BRUTSCHE ET AL.

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
updated	searches	4/24/2006	TTN
as on	search	↓	↓
note	10/4/05	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR